Sea	rch	No	tes



Application/6	Control No.	Applicant(s)/Patent unde Reexamination	r
09/875,444		BAIRD ET AL.	
Examiner		Art Unit	,
Isaac M. Wo	00	2166	

SEARCHED			
Class	Subclass	Date	Examiner
,			
•			
	•		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
search - S	SPAT- text See history printout	7/10/2007	IW

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See search history printout(s), ACM, IEEE, Google	7/10/2007	IW ·
· · · · · · · · · · · · · · · · · · ·		_